

Search Notes

Application/Control No.

10/621,417

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

MOTOYAMA, HAJIME

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	233-235, 248, 250	2/4/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
347	234, 248	2/4/2006	HP
PGPub Text Search		2/4/2006	HP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	2/4/2006	HP